

Transistors

●Absolute maximum ratings (Ta=25°C)

Parameter	Symbol	Limits	Unit
Drain-source voltage	V _{DSS}	30	V
Gate-source voltage	V _{GSS}	±20	V
Drain current	Continuous	I _D	100 mA
	Pulsed	I _{DP} *1	200 mA
Reverse drain current	Continuous	I _{DR}	100 mA
	Pulsed	I _{DRP} *1	200 mA
Total power dissipation (Tc=25°C)	P _D *2	150	mW
Channel temperature	T _{ch}	150	°C
Storage temperature	T _{stg}	-55~+150	°C

*1 Pw≤10μs, Duty cycle≤50%

*2 With each pin mounted on the recommended lands.

●Electrical characteristics (Ta=25°C)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Gate-source leakage	I _{gss}	-	-	±1	μA	V _{Gs} =±20V, V _{Ds} =0V
Drain-source breakdown voltage	V _{(BR)DSS}	30	-	-	V	I _D =10μA, V _{Gs} =0V
Zero gate voltage drain current	I _{DSS}	-	-	1.0	μA	V _{Ds} =30V, V _{Gs} =0V
Gate threshold voltage	V _{Gs(th)}	0.8	-	1.5	V	V _{Ds} =3V, I _D =100μA
Static drain-source on-stage resistance	R _{DS(on)}	-	5	8	Ω	I _D =10mA, V _{Gs} =4V
	R _{DS(on)}	-	7	13	Ω	I _D =1mA, V _{Gs} =2.5V
Forward transfer admittance	Y _{fs}	20	-	-	mS	I _D =10mA, V _{Ds} =3V
Input capacitance	C _{iss}	-	13	-	pF	V _{Ds} =5V
Output capacitance	C _{oss}	-	9	-	pF	V _{Gs} =0V
Reverse transfer capacitance	C _{rss}	-	4	-	pF	f=1MHz
Turn-on delay time	t _{d(on)}	-	15	-	ns	I _D =10mA, V _{DD} =5V
Rise time	t _r	-	35	-	ns	V _{Gs} =5V
Turn-off delay time	t _{d(off)}	-	80	-	ns	R _L =500Ω
Fall time	t _f	-	80	-	ns	R _{Gs} =10Ω

●Electrical characteristic curves

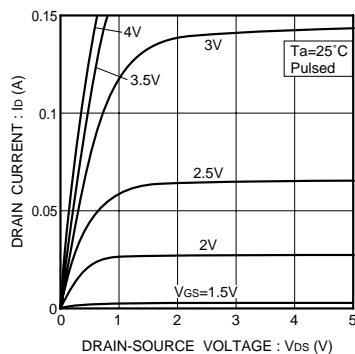


Fig.1 Typical output characteristics

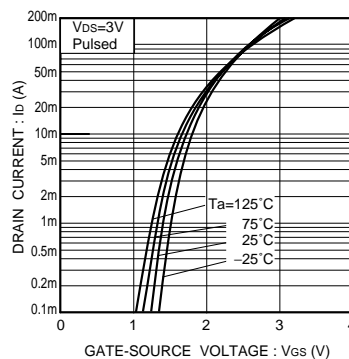


Fig.2 Typical transfer characteristics

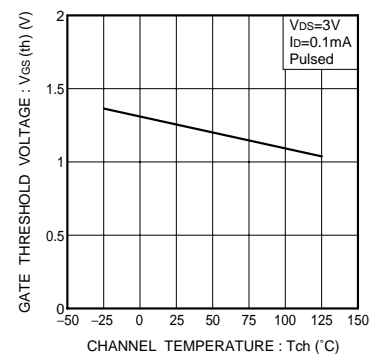


Fig.3 Gate threshold voltage vs. channel temperature

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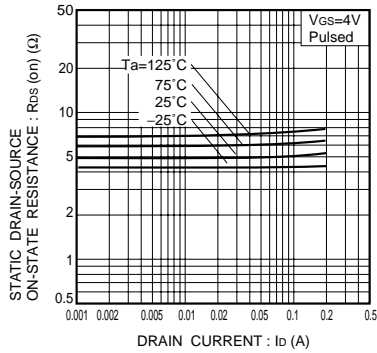


Fig.4 Static drain-source on-state resistance vs. drain current (I)

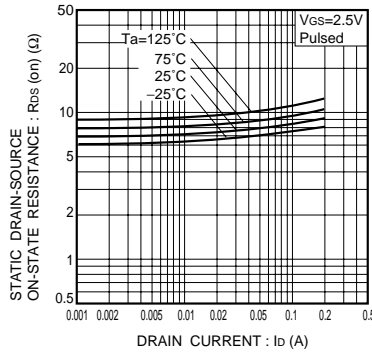


Fig.5 Static drain-source on-state resistance vs. drain current (II)

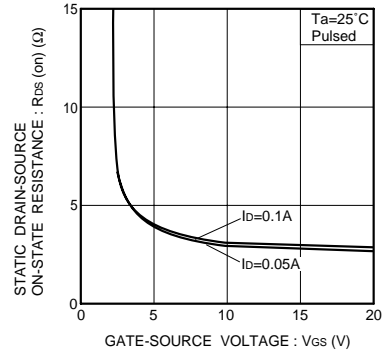


Fig.6 Static drain-source on-state resistance vs. gate-source voltage

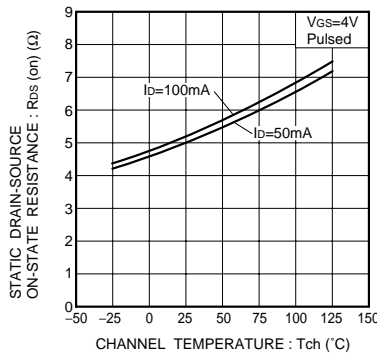


Fig.7 Static drain-source on-state resistance vs. channel temperature

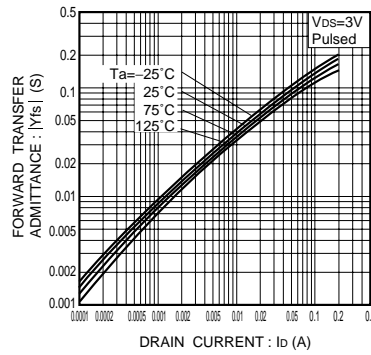


Fig.8 Forward transfer admittance vs. drain current

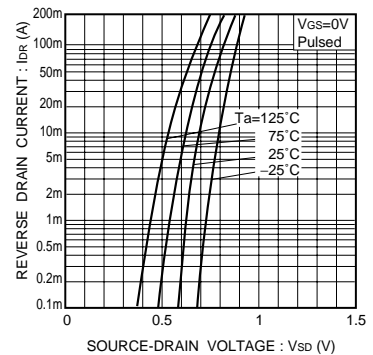


Fig.9 Reverse drain current vs. source-drain voltage (I)

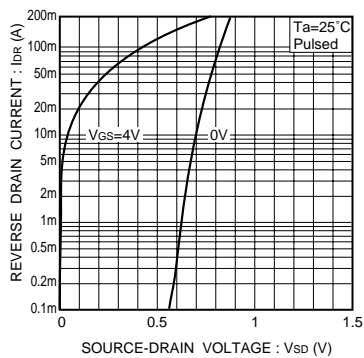


Fig.10 Reverse drain current vs. source-drain voltage (II)

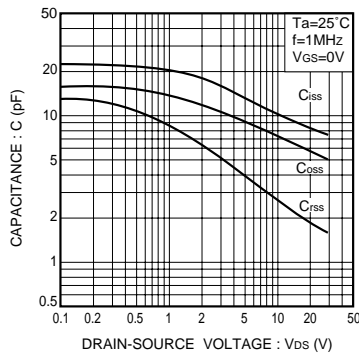


Fig.11 Typical capacitance vs. drain-source voltage

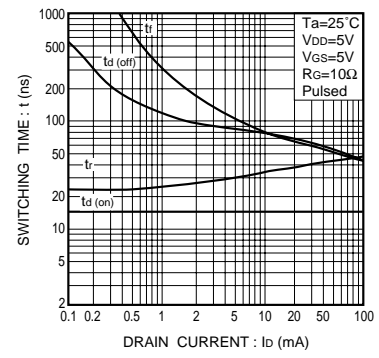


Fig.12 Switching characteristics (See Figures 13 and 14 for the measurement circuit and resultant waveforms)

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● Switching characteristics measurement circuit

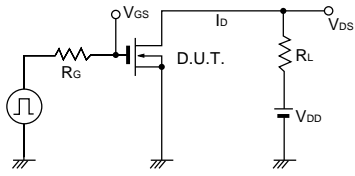


Fig.13 Switching time measurement circuit

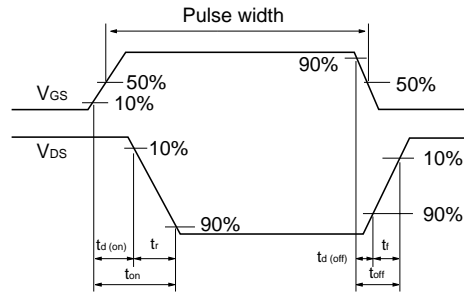


Fig.14 Switching time waveforms